

FDMQ8403

GreenBridge™ Series of High-Efficiency Bridge Rectifiers

N-Channel PowerTrench® MOSFET

100 V, 6 A, 110 mΩ

Features

- Max $r_{DS(on)}$ = 110 mΩ at V_{GS} = 10 V, I_D = 3 A
- Max $r_{DS(on)}$ = 175 mΩ at V_{GS} = 6 V, I_D = 2.4 A
- Substantial efficiency benefit in PD solutions
- RoHS Compliant

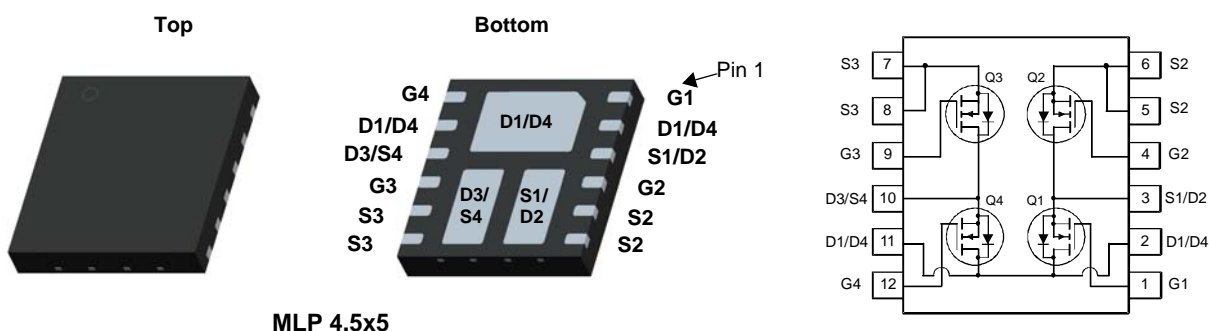


General Description

This quad MOSFET solution provides ten-fold improvement in power dissipation over diode bridge.

Application

- High-Efficiency Bridge Rectifiers



MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|----------------|--|-------------|------------------|
| V_{DS} | Drain to Source Voltage | 100 | V |
| V_{GS} | Gate to Source Voltage | ± 20 | V |
| I_D | Drain Current -Continuous (Package limited) $T_C = 25^\circ\text{C}$ | 6 | A |
| | -Continuous (Silicon limited) $T_C = 25^\circ\text{C}$ | 9 | |
| | -Continuous $T_A = 25^\circ\text{C}$ (Note 1a) | 3.1 | |
| | -Pulsed | 12 | |
| P_D | Power Dissipation $T_C = 25^\circ\text{C}$ | 17 | W |
| | Power Dissipation $T_A = 25^\circ\text{C}$ (Note 1a) | 1.9 | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to +150 | $^\circ\text{C}$ |

Thermal Characteristics

| | | | | |
|-----------------|---|-----------|-----|--------------------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 65 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 135 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|-----------|-----------|------------|------------|
| FDMQ8403 | FDMQ8403 | MLP 4.5x5 | 13 " | 12 mm | 3000 units |

Electrical Characteristics $T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | |
|--------------------------------------|---|---|-----|----|-----------|------------------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$ | 100 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$, referenced to $25\text{ }^{\circ}\text{C}$ | | 72 | | mV/ $^{\circ}\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 80\text{ V}$, $V_{GS} = 0\text{ V}$ | | | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$ | | | ± 100 | nA |

On Characteristics

| | | | | | | |
|--|--|---|---|-----|-----|------------------------|
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250\text{ }\mu\text{A}$ | 2 | 2.8 | 4 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$, referenced to $25\text{ }^{\circ}\text{C}$ | | -8 | | mV/ $^{\circ}\text{C}$ |
| $r_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{ V}$, $I_D = 3\text{ A}$ | | 85 | 110 | m Ω |
| | | $V_{GS} = 6\text{ V}$, $I_D = 2.4\text{ A}$ | | 115 | 175 | |
| | | $V_{GS} = 10\text{ V}$, $I_D = 3\text{ A}$, $T_J = 125\text{ }^{\circ}\text{C}$ | | 147 | 191 | |
| g_{FS} | Forward Transconductance | $V_{DS} = 10\text{ V}$, $I_D = 3\text{ A}$ | | 6 | | S |

Dynamic Characteristics

| | | | | | | |
|-----------|------------------------------|--|--|-----|-----|----|
| C_{iss} | Input Capacitance | $V_{DS} = 50\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ | | 162 | 215 | pF |
| C_{oss} | Output Capacitance | | | 43 | 60 | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 2.6 | 5 | pF |

Switching Characteristics

| | | | | | | |
|--------------|-------------------------------|---|--|-----|----|----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 50\text{ V}$, $I_D = 3\text{ A}$, $V_{GS} = 10\text{ V}$, $R_{GEN} = 6\text{ }\Omega$ | | 4.1 | 10 | ns |
| t_r | Rise Time | | | 1.2 | 10 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 7.2 | 15 | ns |
| t_f | Fall Time | | | 1.8 | 10 | ns |
| Q_g | Total Gate Charge | $V_{GS} = 0\text{ V to } 10\text{ V}$ | $V_{DD} = 50\text{ V}$, $I_D = 3\text{ A}$ | 3 | 5 | nC |
| Q_g | Total Gate Charge | $V_{GS} = 0\text{ V to } 5\text{ V}$ | | 1.7 | 3 | nC |
| Q_{gs} | Gate to Source Charge | | | 0.9 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | 0.8 | | nC |

Drain-Source Diode Characteristics

| | | | | | | |
|----------|---------------------------------------|---|--|------|-----|----|
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{ V}$, $I_S = 3\text{ A}$ (Note 2) | | 0.86 | 1.3 | V |
| t_{rr} | Reverse Recovery Time | $I_F = 3\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$ | | 33 | 53 | ns |
| Q_{rr} | Reverse Recovery Charge | | | 23 | 37 | nC |

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a $1.5 \times 1.5\text{ in.}$ board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. $65\text{ }^{\circ}\text{C/W}$ when mounted on a 1 in^2 pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4.



b. $135\text{ }^{\circ}\text{C/W}$ when mounted on a minimum pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4.

2. Pulse Test: Pulse Width $< 300\text{ }\mu\text{s}$, Duty cycle $< 2.0\%$.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

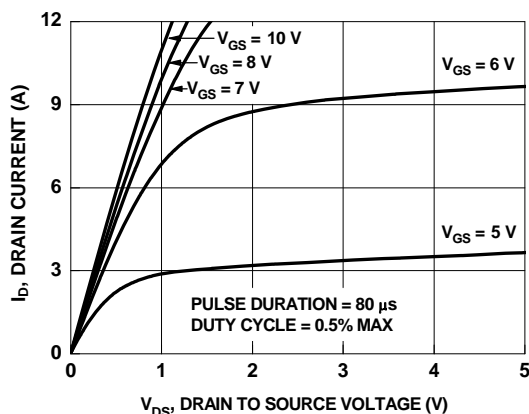


Figure 1. On Region Characteristics

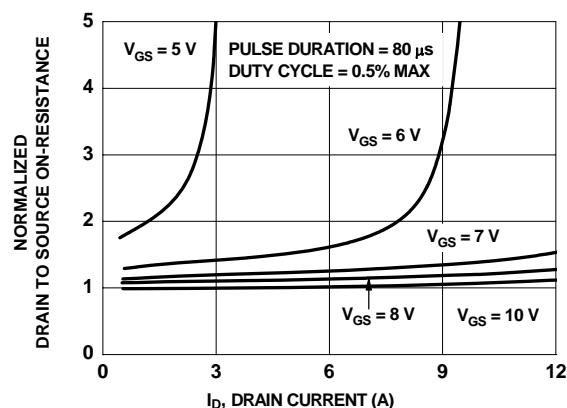


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

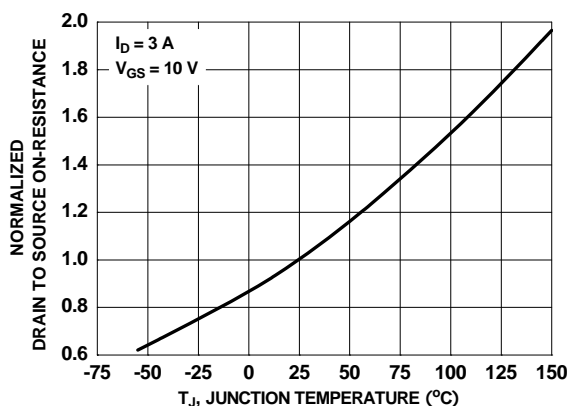


Figure 3. Normalized On Resistance vs Junction Temperature

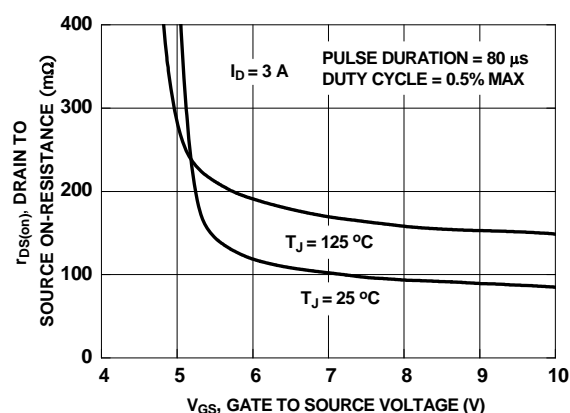


Figure 4. On-Resistance vs Gate to Source Voltage

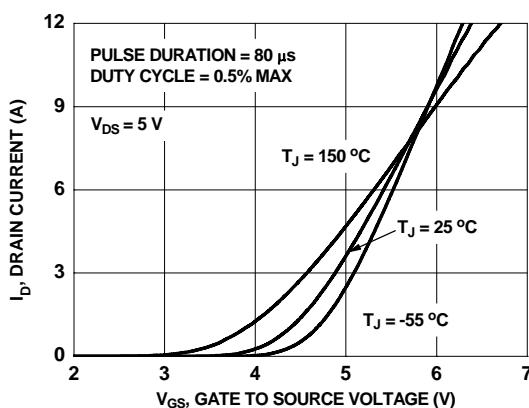


Figure 5. Transfer Characteristics

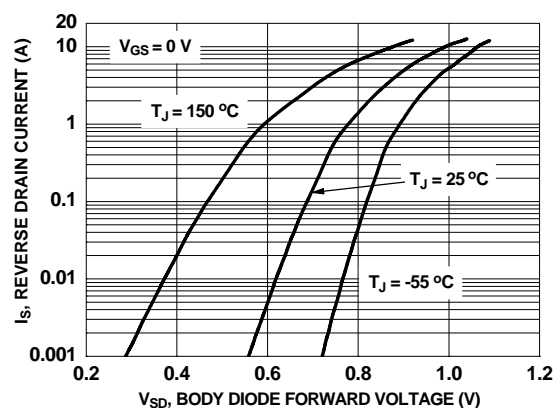


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

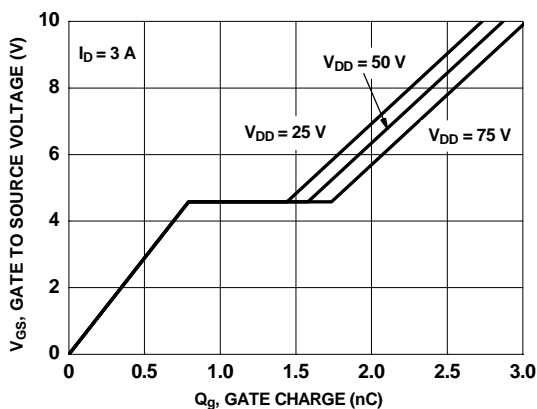


Figure 7. Gate Charge Characteristics

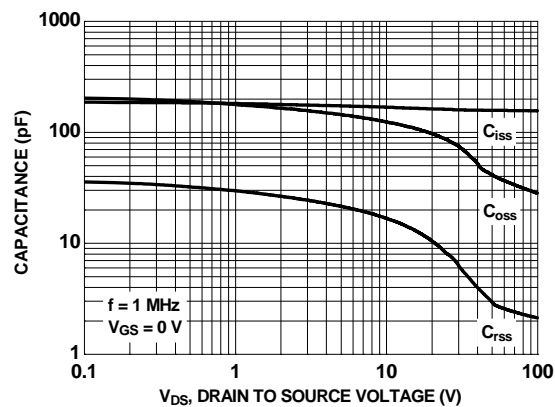


Figure 8. Capacitance vs Drain to Source Voltage

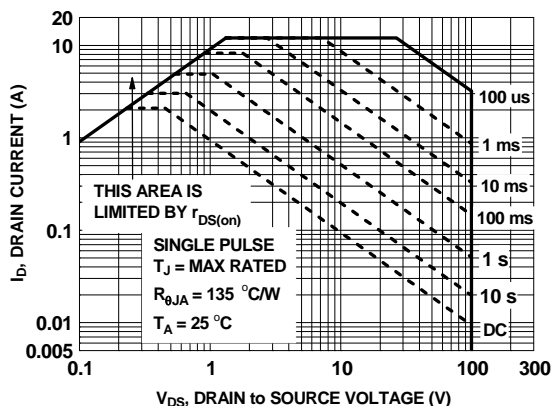


Figure 9. Forward Bias Safe Operating Area

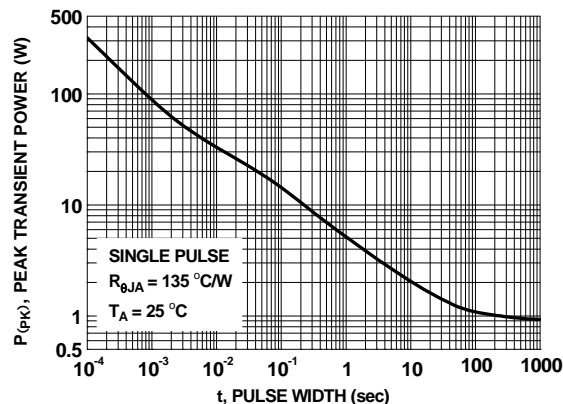


Figure 10. Single Pulse Maximum Power Dissipation

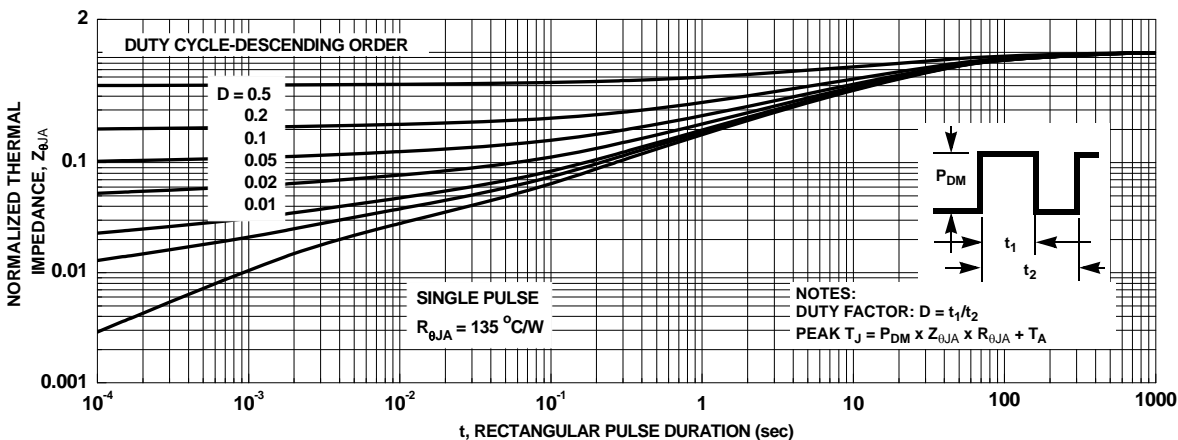


Figure 11. Junction-to-Ambient Transient Thermal Response Curve

